

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DEUTSCH ET AL.	
		Examiner MYRON WYCHE	Art Unit 2617	Page 1 of 1

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*	A US-2006/0031297	02-2006	Zuidema, Edwin	709/206
*	B US-2005/0075093	04-2005	Lei et al.	455/412.1
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